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U.S. **UTILITY** Patent Application

1/11/2 (5) \Q	PATENT DATE
SCANNED Q.A.	

2881

Masato Muraki Yoshikiyo Yui

Form PTO-438A (Rev. 6/99)

.09/733980

Charged-particle beam exposure apparatus, charged-particle beam exposure method, control data determination method, and device manufacturing method using this method

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Formal Drawings 6